TOSHIBA 2SC2880

TOSHIBA TRANSISTOR SILICON NPN TRIPLE DIFFUSED TYPE (PCT PROCESS)

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HIGH VOLTAGE SWITCHING APPLICATIONS

• High Voltage : V_{CEO}=150V

• High Transition Frequency: f_T=120MHz

• PC=0.8~2W (Mounted on Ceramic Substrate)

• Small Flat Package

• Complementary to 2SA1200

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	v_{CBO}	200	V
Collector-Emitter Voltage	v_{CEO}	150	V
Emitter-Base Voltage	$v_{ m EBO}$	5	V
Collector Current	$I_{\mathbb{C}}$	50	mA
Base Current	$I_{\mathbf{B}}$	10	mA
Collector Power Dissipation	$P_{\mathbf{C}}$	500	mW
Collector Power Dissipation	P _C (Note)	800	mW
Junction Temperature	$\mathrm{T_{j}}$	150	°C
Storage Temperature	$\mathrm{T_{stg}}$	-55~150	°C

1.6MAX. 1.7MAX. 0.4±0.05 1.08 0.4-0.05 1.5±0.1 1.2 3 1. BASE 2. COLLECTOR (HEAT SINK) 3. EMITTER PW-MINI JEDEC —

JEITA SC-62

Unit in mm

Weight: 0.05g (Typ.)

MARKING

TOSHIBA

(Note): Mounted on ceramic substrate (250mm²×0.8t)

Type Name hFE Rank

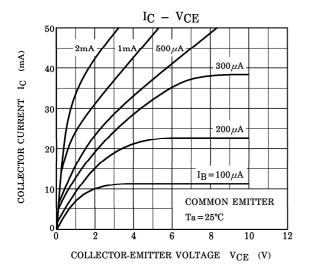
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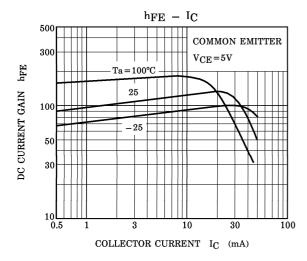
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

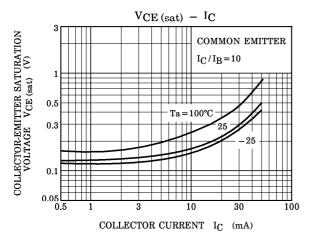
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	I_{CBO}	$V_{CB} = 200V, I_{E} = 0$	_		0.1	μ A
Emitter Cut-off Current	$I_{ m EBO}$	$V_{EB}=5V, I_{C}=0$	_	_	0.1	μ A
DC Current Gain	hFE (Note)	$V_{\rm CE}$ =5V, $I_{\rm C}$ =10mA	70	_	240	
Collector-Emitter Saturation Voltage	V _{CE} (sat)	$I_{C}=10$ mA, $I_{B}=1$ mA	_	_	0.5	V
Base-Emitter Voltage	$ m V_{BE}$	$V_{\rm CE}$ =5V, $I_{\rm C}$ =30mA	_	_	1	V
Transition Frequency	${ m f_T}$	$V_{\rm CE}$ =30V, $I_{\rm C}$ =10mA	_	120		MHz
Collector Output Capacitance	C_{ob}	$V_{CB} = 10V, I_{E} = 0, f = 1MHz$	_	3.5	5.0	pF

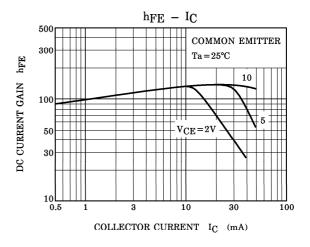
(Note) : h_{FE} Classification $O:70\sim140$, $Y:120\sim240$

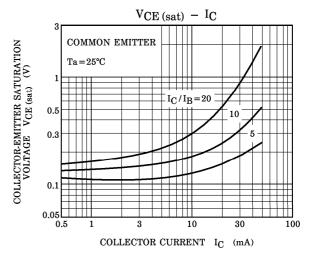
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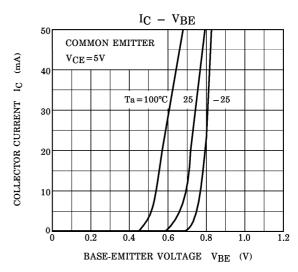




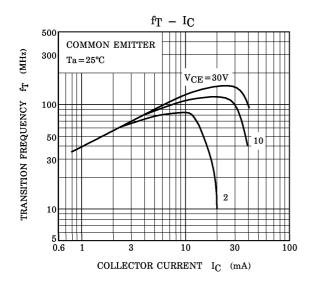


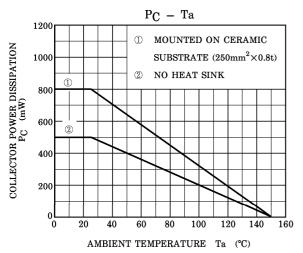


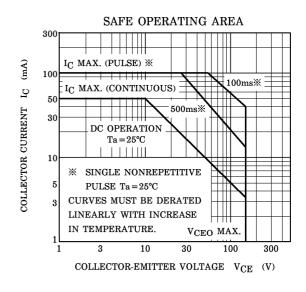




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